

# SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:	
客戶料號 CUSTOMER'S P/N	:	
料號 PART NUMBER	:	KBAN3216G245H01
規格 DESCRIPTION	:	Chip Antenna 3216 L Ant 2.45G Type H01 ; Type: Ceramic Antenna
版本 VERSION	:	V1.1
日期 ISSUE DATE	:	2021/03/11



	エ 程 部 R&D CENTER	
承 認 APPROVAL	確認 CHECKED	製 作 DRAWN
Ziv	Alex	Jerry



萬誠科技股份有限公司

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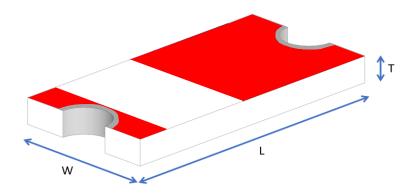
電話: (02) 2898-2220 傳真: (02) 2898-5055 manufacturer:

### OneWave Electronic Co., Ltd.

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# 3216 Chip Ceramic antenna

# For Bluetooth / WLAN Applications



### P/N: KBAN3216G245H01

	Dimension (mm)
L	3.23 ± 0.20
W	1.66 ± 0.20
Т	0.45 ± 0.20

### **Part Number Information**

<b>KBAN</b>	<u>3216</u>	<u>G</u>	<u>245</u>	H	<u>01</u>
Α	В	С	D	Е	F

Α	Product Series	Antenna
B	Dimension L x W	3.2 x 1.6mm (±0.2mm)
С	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
Ε	Feeding mode	PIFA & Single Feeding
F	Antenna type	Type = 01

## **1. Electrical Specification**

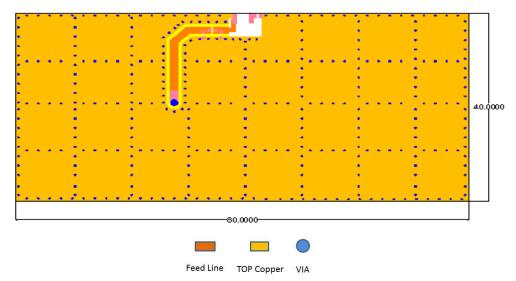
Specification									
Part Number	KBAN3216G245H01								
Central Frequency	2450	MHz							
Bandwidth	120 (Min.)	MHz							
Return Loss	-6.5 (Max)	dB							
Peak Gain	1.73	dBi							
Impedance	50	Ohm							
Operating Temperature	-40~+110	°C							
Maximum Power	4	W							
Resistance to Soldering Heats	10 ( @ 260°C )	sec.							
Polarization	Linear								
Azimuth Beamwidth	Omni-directional								
Termination	Cu / Sn (Leadless)								

Remark : Bandwidth & Peak Gain was measured under evaluation board of next page



### 2. Recommended PCB Pattern Evaluation Board Dimension

If the design is not based on the Layout suggestions in our company's specifications, which may result in differences in antenna characteristics and quality in subsequent production, our company will not be responsible for any false claims.



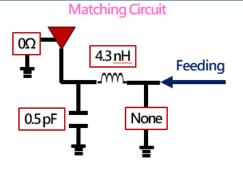
### 2<sup>nd</sup> Evaluation Board Dimension

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### **Suggested Matching Circuit**

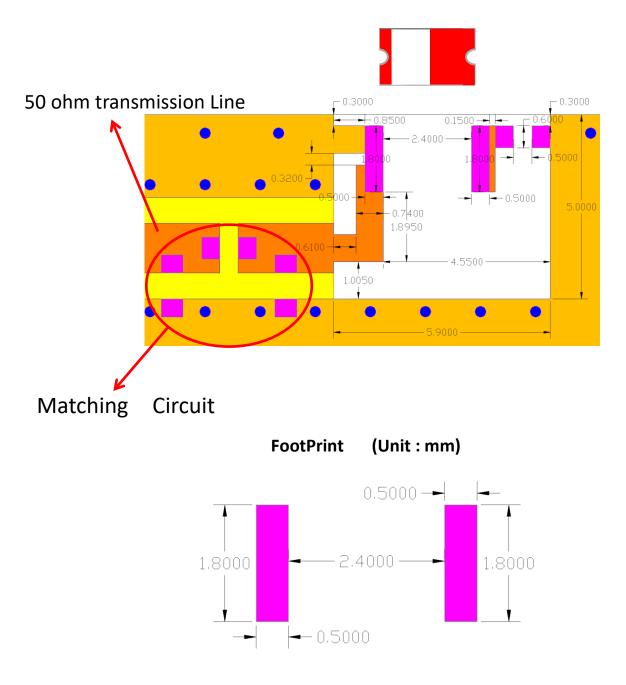
**Important information:** 

It is recommended to use high-precision inductors with a precision of  $\pm$  0.1~0.3nH and capacitors with a precision of  $\pm$  0.1pF for matching components

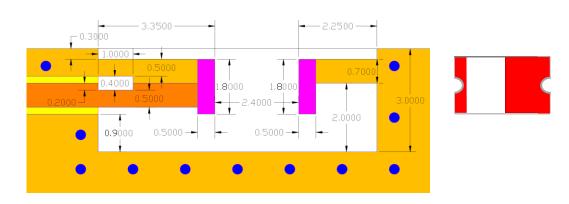




Layout Dimensions in Clearance area(Size=5.9\*5.0mm)

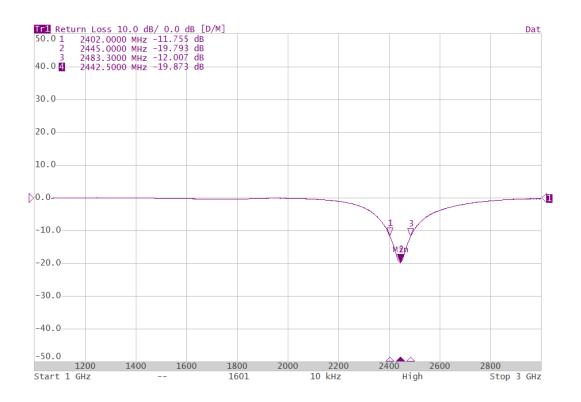


• 2<sup>nd</sup> Layout Dimensions in Clearance area(Size=8.0\*3.0mm)



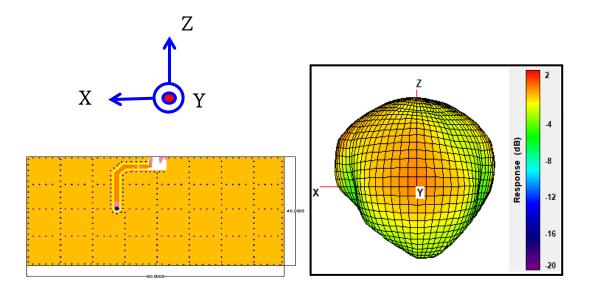


#### 3. Measurement Results Return Loss



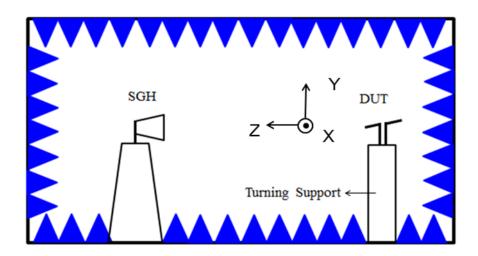


#### **Radiation Pattern**



	Efficiency	Peak Gain	Directivity
2400MHz	78.66 %	1.64 dBi	2.68 dBi
2450MHz	81.58 %	1.73 dBi	2.61 dBi
2500MHz	79.88 %	1.68 dBi	2.65 dBi

Chamber Coordinate System





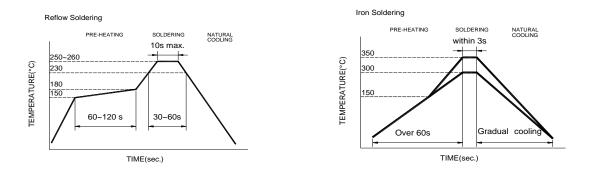
# 4.Reliability and Test Condictions

ITEM	REQUIREMENTS	TEST CONDITION
Solderability	1. Wetting shall exceed 90% coverage	Pre-heating temperature:150°C/60sec.
Colderability	2. No visible mechanical damage	Solder temperature:230 $\pm$ 5 $^{\circ}$ C
		Duration:4±1sec.
	TEMP (°C)	Solder:Sn-Ag3.0-Cu0.5
	4±1 sec.	Flux for lead free: rosin
	230°C 4⊥1 sec.	That for lead free. Toshi
	150°C	
	60sec	
	> 00sec (	
Solder heat Resistance	<ol> <li>No visible mechanical damage</li> <li>Central Freq. change :within ± 6%</li> </ol>	Pre-heating temperature:150°C/60sec.
Resistance		Solder temperature:260±5°C
	TEMP (°C)	Duration:10±0.5sec.
	260°C 10±0.5 sec.	Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin
		Flux for lead free. Tosifi
	150°C	
	60sec \	
Component	1. No visible mechanical damage	The device should be reflow
Adhesion (Push test)		soldered(230 $\pm$ 5 $^{\circ}$ C for 10sec.) to a tinned
(Fusiliesi)		copper substrate A dynometer force
		gauge should be applied the side of the
		component. The device must with-ST-F 0.5 Kg without failure of the termination
		attached to component.
Component	1. No visible mechanical damage	Insert 10cm wire into the remaining open
Adhesion		eye bend ,the ends of even wire lengths
(Pull test)		upward and wind together.
(1 011 (031)		Terminal shall not be remarkably
		damaged.
Thermal shock	1. No visible mechanical damage	+110°C=>30±3min
inoma onook	-	-40°C=>30±3min
	2. Central Freq. change :within ±6%	Test cycle:10 cycles
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal
	1 +110±5℃ 30±3	condition for 2~3 hours before
	2 Room Within	measuring.
	Temperature 3sec	g.
	3 -40±2°C 30±3	
	4 Room Within	
	Temperature 3sec	
Resistance to	1. No visible mechanical damage	Temperature: +110±5℃
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal
		condition for 2~3 hours before
		measuring.
Resistance to	1. No visible mechanical damage	Temperature:-40±5℃
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal
		condition for 2~3 hours before
		measuring.
Humidity	1. No visible mechanical damage	Temperature: 40±2°C
	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH
	3. No disconnection or short circuit.	Duration: 1000±12hrs
		The chip shall be stabilized at normal
		condition for 2~3 hours before
		measuring.
		monouring



#### **5.Soldering and Mounting**

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



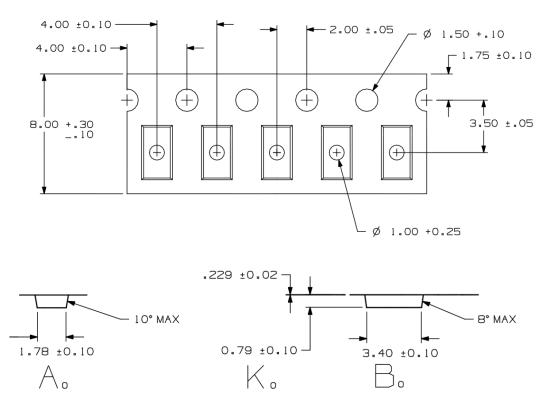
Recommended temperature profiles for re-flow soldering in Figure 1.

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

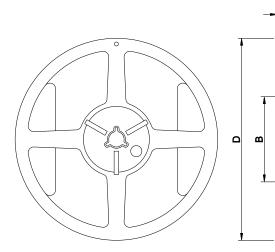
- Preheat circuit and products to  $150^\circ$ C
- · Never contact the ceramic with the iron tip
- · Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.

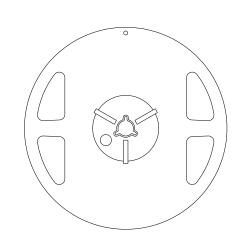
# 6.Packaging Information

#### Tape Specification:



Reel Specification: (7", Ф180 mm)





7" x 8 mm

C

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000

#### 7. Storage and Transportation Information

#### **Storage Conditions**

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~  $40^{\circ}$ C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

#### **Transportation Conditions**

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.